

PTO/SB/08A (04-03)

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**INFORMATION DISCLOSURE
STATEMENT BY APPLICANT**

(use as many sheets as necessary)

Page 1 of 2

Complete if Known

Application Number	09/694,782
Filing Date	October 24, 2000
First Named Inventor	Donald Francis Specht
Art Unit	2614
Examiner Name	Unassigned
Attorney Docket Number	040092-001300US

U.S. PATENT DOCUMENTS

Examiner	Cite No. ¹	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number Kind Code ² (if known)			
BL	1	US 5,835,637	11-10-1998	Houchin J. Scott et al.	

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FOREIGN PATENT DOCUMENTS

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		Country Code ³	Number ⁴	Kind Code ⁵ (if known)				

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Page	2	of	2	Attorney Docket Number	040092-001300US

NON PATENT LITERATURE DOCUMENTS			
Examiner Initials *	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²
BL	2	INQUE et al., Adaptive Image Sharpening Method Using Edge Sharpness, IEICE Transactions on Information and Systems, Institute of Electronics Information and Comm. Eng. Tokyo, JP, Vol. E76-D, No. 10, October 1993, pages 1174-1180.	
BL	3	SCHAVEMAKER et al., Image Sharpening by morphological filtering, Pattern Recognition, Pergamon Press Inc., Elmsford, N.Y., US, vol. 33, No. 6, Jun3 2000, pages 997-1012.	

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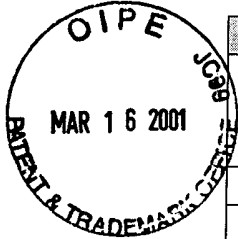
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INFORMATION DISCLOSURE CITATION

October 24, 2000

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U.S. PATENT DOCUMENTS

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FOREIGN PATENT DOCUMENTS

	Document Number	Date	Country	Class	Sub-Class	Translation Yes/No

OTHER DOCUMENTS (Including Author, Title, Date, etc.)

BL	Sylvia S. Shen, John E. Lindgren & Paul M. Payton, SPIE-The International Society for Optical Engineering, Reprinted from Neural and Stochastic Methods in Image and Signal Processing III, Panchromatic Band Sharpening of Multispectral Image Data to Improve Machine Exploitation Accuracy, SPIE Volume 2304, July 28-29, 1994, pages 124-131.
BL	John E. Lindgren & Steven Kilston, A Projective Pan Sharpening Algorithm, Lockheed Martin Missiles & Space, Space Imaging, Incorporated, SPIE 1996.
PL	A. Evan Iverson & James R. Lersch, Adaptive Image Sharpening using Multiresolution Representations, SPIE Volume 2231, April 5, 1994, pages 1-12.

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Brooks

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